

## Single P-Channel MOSFET

### ■ DESCRIPTION

SMC2207E is the P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced trench technology devices are well suited for high efficiency fast switching applications, low in-line power loss needed in small outline surface mount package.

### ■ PART NUMBER INFORMATION

**SMC 2207 E SC - TR G**

a	b	c	d	e	f
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a : Company name.

b : Product Serial number.

c : ESD

d : Package code      SC: SOT-523

e : Handling code      TR: Tape&Reel

f : Green produce code G: *RoHS Compliant*

### ■ FEATURES

$$V_{DS} = -20V, \quad I_D = -0.6A$$

$$R_{DS(ON)} = 450m\Omega (\text{Typ.}) @ V_{GS} = -4.5V$$

$$R_{DS(ON)} = 630m\Omega (\text{Typ.}) @ V_{GS} = -2.5V$$

$$R_{DS(ON)} = 850m\Omega (\text{Typ.}) @ V_{GS} = -1.8V$$

$$R_{DS(ON)} = 1060m\Omega (\text{Typ.}) @ V_{GS} = -1.5V$$

$$R_{DS(ON)} = 1700m\Omega (\text{Typ.}) @ V_{GS} = -1.2V$$

◆ Fast switch

◆ 1.2V Low gate drive applications

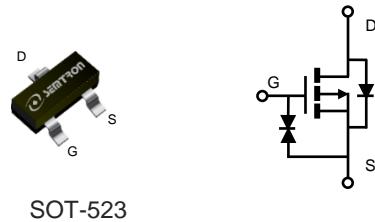
◆ Improved dv/dt capability

### ■ APPLICATIONS

◆ Hand-Held Instruments

◆ Load Switch

◆ Battery Protection



SOT-523

### ■ ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-Source Voltage	-20	V
$V_{GSS}$	Gate-Source Voltage	$\pm 8$	V
$I_D$	Continuous Drain Current	$T_A=25^\circ\text{C}$	-0.6
		$T_A=70^\circ\text{C}$	-0.48
$I_{DM}$	Pulsed Drain Current <sup>A</sup>	-1.6	A
$P_D$	Power Dissipation <sup>B</sup>	$T_A=25^\circ\text{C}$	0.3
		$T_A=70^\circ\text{C}$	0.2
$T_J$	Operation Junction Temperature	-55/150	$^\circ\text{C}$
$T_{STG}$	Storage Temperature Range	-55/150	$^\circ\text{C}$

### ■ THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient <sup>C</sup>	$t \leq 10s$	-	$^\circ\text{C}/\text{W}$
	Thermal Resistance Junction to Ambient <sup>C</sup>		420	
$R_{\theta JC}$	Thermal Resistance Junction to Case <sup>C</sup>	Steady-State	-	

**ELECTRICAL CHARACTERISTICS( $T_A = 25^\circ\text{C}$  Unless otherwise noted)**

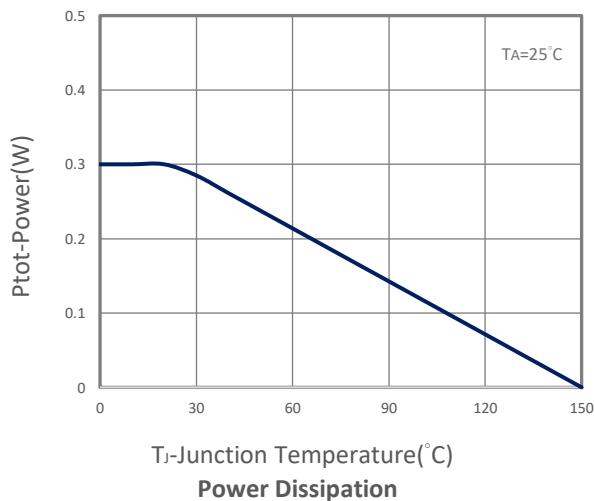
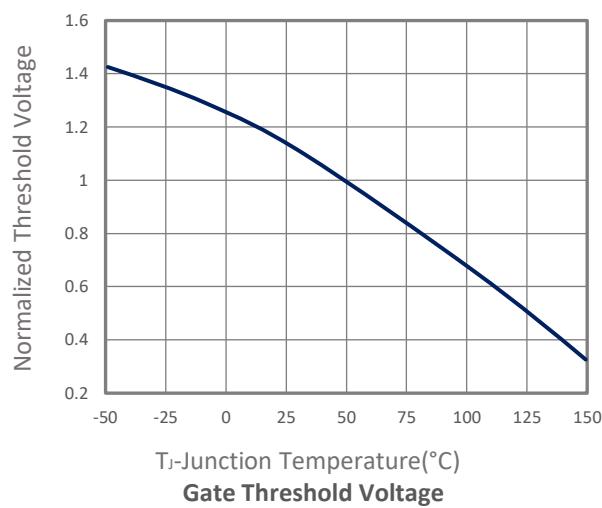
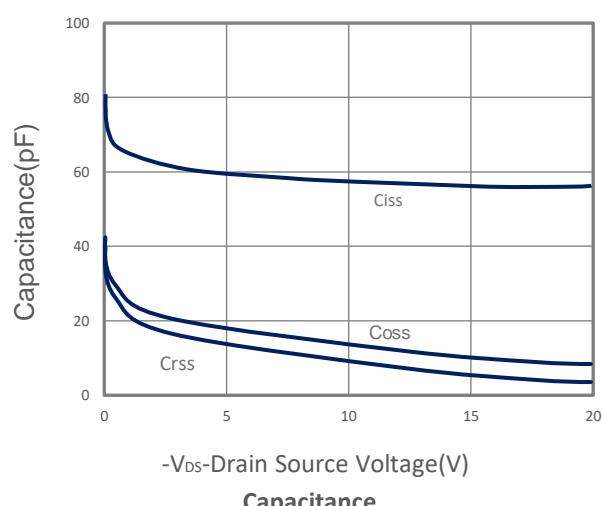
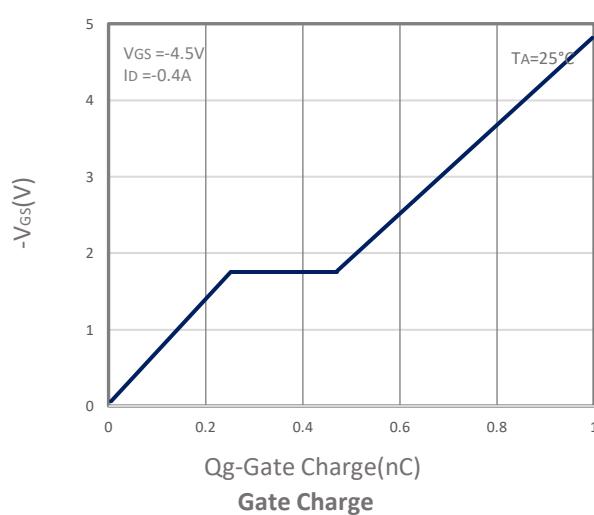
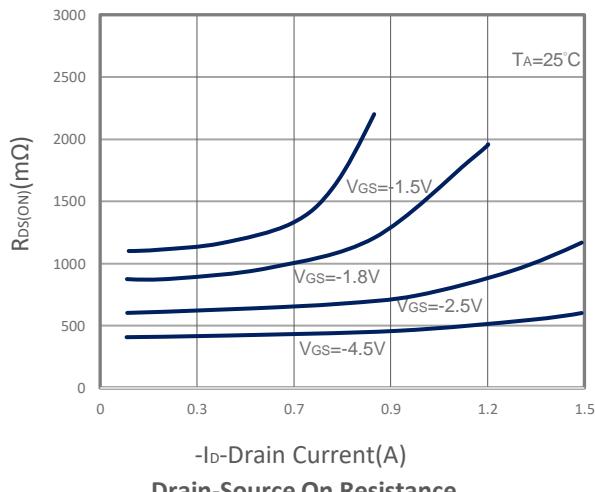
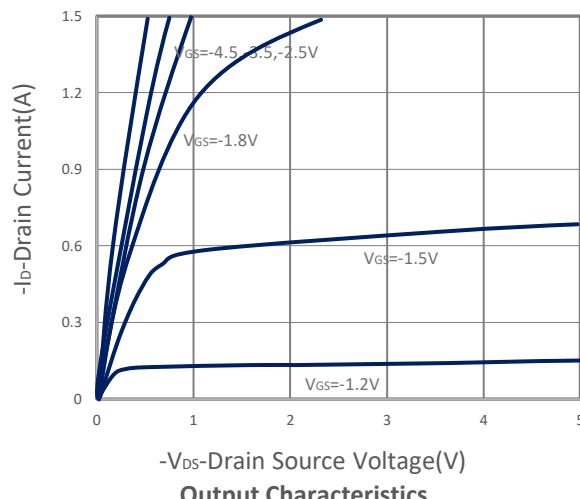
Symbol	Parameter	Condition	Min	Typ	Max	Unit	
<b>Static Parameters</b>							
$BV_{DSS}$	Drain-Source Breakdown Voltage <sup>D</sup>	$V_{GS} = 0\text{V}, I_D = -250\mu\text{A}$	-20			V	
$V_{GS(\text{th})}$	Gate Threshold Voltage <sup>D</sup>	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	-0.3	-0.6	-1	V	
$I_{GSS}$	Gate Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = \pm 8\text{V}$			$\pm 20$	nA	
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -20\text{V}, V_{GS} = 0\text{V}$ $T_J = 25^\circ\text{C}$			-1	$\mu\text{A}$	
		$V_{DS} = -16\text{V}, V_{GS} = 0\text{V}$ $T_J = 75^\circ\text{C}$			-10		
$R_{DS(\text{ON})}$	Drain-source On-Resistance <sup>D</sup>	$V_{GS} = -4.5\text{V}, I_D = -0.4\text{A}$	450	580		$\text{m}\Omega$	
		$V_{GS} = -2.5\text{V}, I_D = -0.3\text{A}$	630	840			
		$V_{GS} = -1.8\text{V}, I_D = -0.15\text{A}$	850	1150			
		$V_{GS} = -1.5\text{V}, I_D = -0.1\text{A}$	1060	1600			
		$V_{GS} = -1.2\text{V}, I_D = -0.1\text{A}$	1700	2700			
<b>Source-Drain Diode</b>							
$V_{SD}$	Diode Forward Voltage <sup>B</sup>	$I_S = -1\text{A}, V_{GS} = 0\text{V}$			-1.0	V	
$I_S$	Continuous Source Current				-0.4	A	
<b>Dynamic and Switching Parameters</b>							
$Q_g$	Total Gate Charge	$V_{DS} = -10\text{V}, V_{GS} = -4.5\text{V}$ $I_D = -0.6\text{A}$		1		nC	
$Q_{gs}$	Gate-Source Charge			0.14			
$Q_{gd}$	Gate-Drain Charge			0.18			
$C_{iss}$	Input Capacitance	$V_{DS} = -10\text{V}, V_{GS} = 0\text{V}$ $f = 1\text{MHz}$		60		pF	
$C_{oss}$	Output Capacitance			18			
$C_{rss}$	Reverse Transfer Capacitance			15			
$t_{d(on)}$	Turn-On Time <sup>E</sup>	$V_{DD} = -10\text{V}, V_{GEN} = -4.5\text{V},$ $R_G = 10\Omega, I_D = -0.2\text{A}$		6.2		nS	
$t_r$	Turn-Off Time <sup>E</sup>			5.6			
$t_{d(off)}$				30			
$t_f$				18			

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

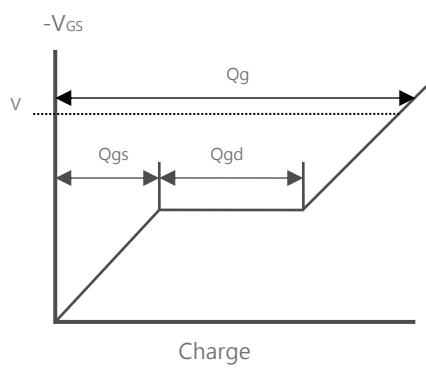
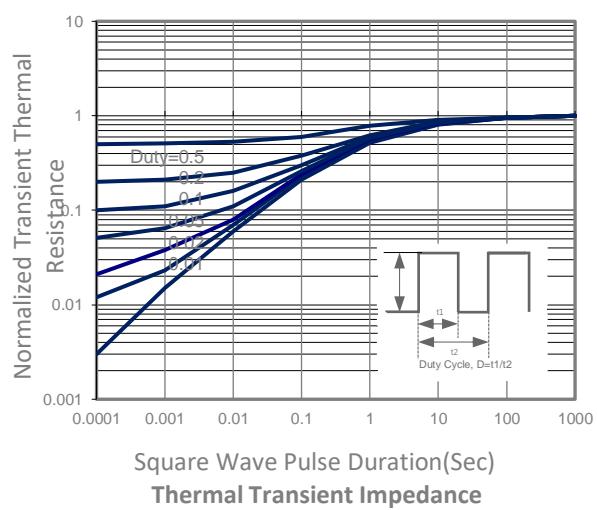
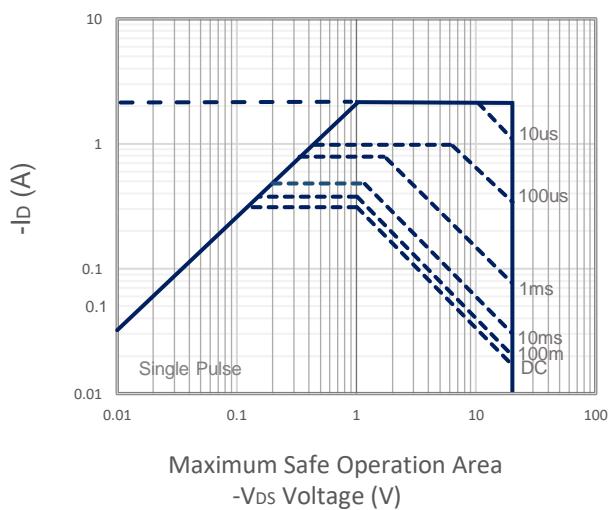
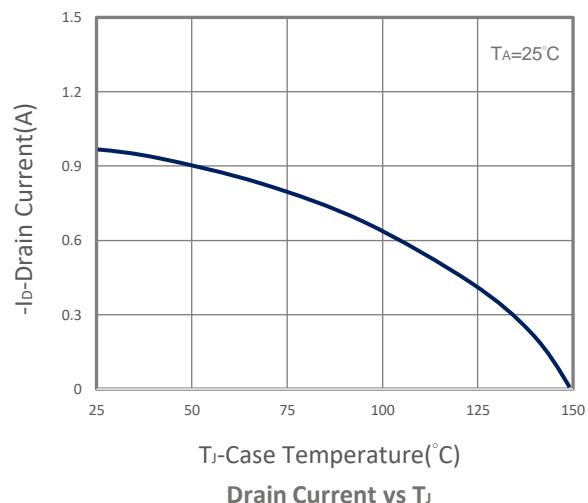
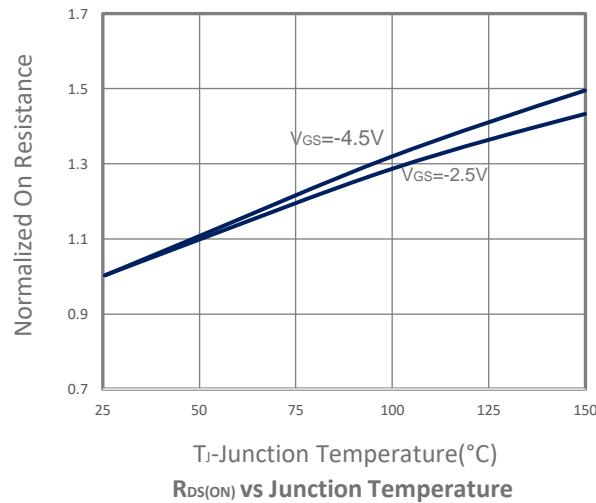
- A. The value of  $R_{\theta JA}$  is measured with the device in a still air environment with maximum junction temperature  $T_J(\text{MAX}) = 150^\circ\text{C}$  (initial temperature  $T_A = 25^\circ\text{C}$ )..
- B. The  $T_J(\text{MAX}) = 150^\circ\text{C}$ , using junction-to-ambient thermal resistance.
- C. Surface-mounted on FR-4 board using 1 sq-in pad, 2 oz Cu, in a still air environment with  $T_A = 25^\circ\text{C}$ .
- D. The data tested by pulsed, pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$
- E. Pulsed width limited by maximum junction temperature.

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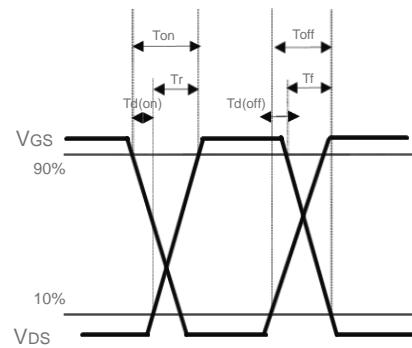
## ■ TYPICAL CHARACTERISTICS



## TYPICAL CHARACTERISTICS

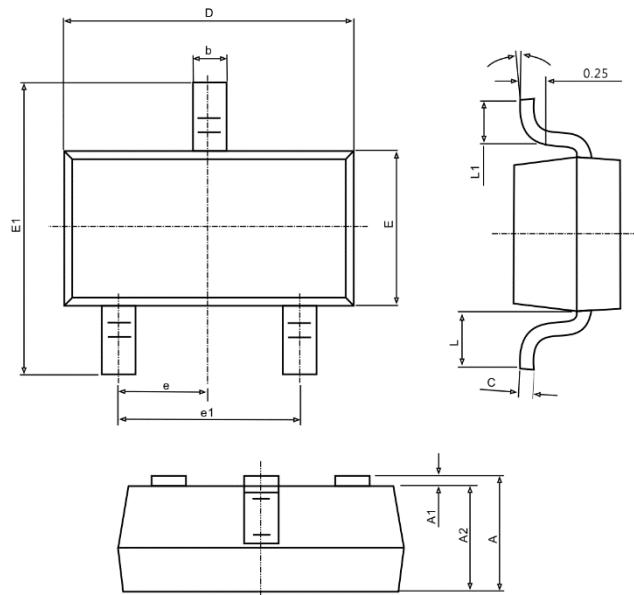


Gate Charge Waveform

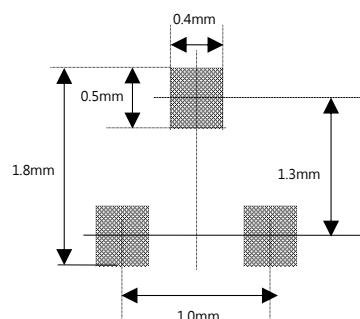


Switching Time Waveform

## SOT-523 PACKAGE DIMENSIONS



**Recommended Land Pattern**



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.700	0.900	0.028	0.035
A1	0.000	0.100	0.000	0.004
A2	0.700	0.800	0.028	0.031
b	0.250	0.350	0.010	0.014
c	0.100	0.200	0.004	0.008
D	1.500	1.750	0.059	0.069
E	0.700	0.900	0.028	0.035
E1	1.400	1.750	0.055	0.069
e	0.500 TYP.		0.020 TYP..	
e1	0.900	1.100	0.035	0.043
L	0.300	0.460	0.012	0.018
L1	0.260	0.460	0.010	0.018
$\Theta$	$0^\circ$	$8^\circ$	$0^\circ$	$8^\circ$